

## Application Note: SQ33065 6V to 75V Synchronous Buck Controller With Wide Duty Cycle Range

Preliminary Specification

## **General Description**

The SQ33065 is 75V synchronous buck controller with type III voltage mode control and feedforward. Minimum tens of nanosecond on-time facilitates large step-down ratios. The SQ33065 continues to operate when input voltage decreases to as low as 6V.

VIN over voltage protection is achieved by directly detecting VIN pin voltage to prevent output inverse charging. Cycle-by-cycle over current protection is accomplished by measuring the voltage across the low-side MOSFET or current sense resistor. Forced-PWM (FPWM) eliminates frequency variation and a selectable diode emulation lowers power consumption at light-load conditions. The switching frequency as high as 1 MHz can be set or synchronized to an external clock.

## **Ordering Information**

	) • Package Code • Optional Spec Code	
Ordering Number	Package type	Note
SQ33065WAQ	QFN3.5x4.5-20	

### Features

- 6V to 75V Input Voltage Range
- Switching Frequency: 100kHz~1MHz
  SYNC In/Out Capability
- Soft-Start or Voltage Tracking
- 0.8V±1% Reference Voltage
- Minimum On-Time: 60ns typical
- Minimum Off-Time: 200ns typical
- Type III Voltage-Mode Control With Feedforward
- High Gain-Bandwidth Error Amplifier
- Open-Drain Power Good Indicator
- Protection Features
  - Cycle-by-cycle Over current Protection
  - VIN Over voltage Protection
  - Input UVLO with Hysteresis
  - VCC and Gate UVLO Protection
  - Thermal Shutdown Protection with Hysteresis
  - Compact Package: QFN3.5x4.5-20

## Applications

- Telecom Power Application
- RF Power Application
- Commercial Drone Application
- DSP Power Application



Figure 1. Typical Application



## Pinout (Top View)



Top mark: **DXY**xyz (Device code: **DXY**, x=year code, y=week code, z= lot number code)

	Pin Name	Pin Number	Pin Description		
	EN/UVLO	1	Enable and UVLO pin		
	RT	2	Switching frequency set pin. A resistor is connected to RT pin and set the operation frequency.		
	SS/TRK	3	Soft-start and voltage tracking pin. A capacitor is connected to set soft-start time.		
	COMP	4	Output of the internal error amplifier.		
	FB	5	Output Feedback Pin.		
	AGND	6	Analog ground.		
	SYNCOUT	7	Synchronization output. Logic output that provides a clock signal that is 180 °out-of phase with the high-side FET gate drive.		
	SYNCIN	8	Synchronization input pin.		
	NC	9	No electrical connection.		
	PGOOD	10	Power Good indicator.		
	ILIM	11	Current limit set and protection pin.		
	PGND	12	Power ground.		
	LO	13	Low side MOSFET gate driver pin.		
	VCC	14	Power supply pin.		
	EP	15	Exposed pad of the package.		
$\sim$	NC	16	No electrical connection.		
	BST	17	Bootstrap supply for the high-side gate driver.		
	НО	18	High side MOSFET gate driver pin.		
	LX	19	Inductor pin. Connect this pin to the switching node of inductor.		
	VIN	20	Voltage supply for VCC LDO regulator and VIN protection pin.		
	EP	-	Exposed pad of the package.		



AN\_SQ33065

## **Block Diagram**





## **Absolute Maximum Ratings**

Absolute Maximum Voltage (Note 1)	
VIN, EN/UVLO, PGOOD	
LX	
ILIM	
VCC, SYNCIN	-0.3V to 14V
BST to LX	0.3V to 14V
FB, COMP, SS/TRK, RT	
BST	
Package Thermal Resistance (Note 2)	
Power Dissipation max. @ TA=25 °C OFN3.5x4.5-20	3.3W
θ <sub>IA</sub>	38 °C/W
θ <sub>JC(top)</sub>	21 °C/W
Junction Temperature Range	150 °C
Lead Temperature (Soldering, 10 sec.)	260 °C
Storage Temperature Range	
Recommended Operating Conditions (Note 3)	22
VIN	6V to 75V
VCC	
Junction Temperature Range	

2

## **Electrical Characteristics**

 $(V_{IN}=48V, V_{EN/UVLO}=1.5V, R_{RT}=25k\Omega, T_j=25^{\circ}C, unless otherwise specified)$ 

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Vin Input Supply & Vin Protection(OVP)						
VIN Voltage Range	VIN		6		75	V
Operating Input Current, not Switching	I <sub>Q-RUN</sub>	$V_{EN/UVLO} = 1.5V, V_{SS/TRK} = 0V$		1		mA
Standby Input Current	I <sub>Q-STBY</sub>	$V_{EN/UVLO} = 1V$		0.4		mA
Shutdown Input Current	IQ-SDN	$V_{EN/UVLO} = 0V, V_{VCC} < 1V$		10		μΑ
VIN OVP	VIN_OVP			88		V
VIN OVP Hysteresis	VIN_OVP_hys			6		V
VCC Regulator						
VCC Regulation Voltage	Vvcc	$\begin{array}{l} V_{SS/TRK} = 0V,  9V \leq V_{VIN} \leq \\ 75V, 0mA < I_{VCC} \leq 20mA \end{array}$		7.5		V
VIN to VCC Dropout Voltage	Vvcc-ldo	$V_{IN} = 6 V, V_{SS/TRK} = 0 V,$ $I_{VCC} = 20 mA$		0.25		V
VCC Short-circuit Current	Isc-ldo	$V_{SS/TRK} = 0V, VCC = 6V$		50		mA
VCCUVLO Threshold	VUVLO_H	VCC rising		4.75		V
VCCUVLO Hysteresis	VUVLO_HYS	Rising threshold – falling threshold		250		mV
Mimmum External Bias Supply Voltage	Vvcc-ext	Voltage required to disable VCC regulator	8			V
External VCC Input Current, not Switching	Ivcc	$V_{SS/TRK} = 0V, V_{VCC} = 13V$		1		mA
Enable And Input UVLO						
Shutdown to Standby Threshold	V <sub>SDN</sub>	V <sub>EN/UVLO</sub> rising		375		mV



Shutdown Threshold	V <sub>SDN-HYS</sub>	EN/UVLO rising – falling		35		mV
Hysteresis		threshold				
Standby to Operating Threshold	$V_{\text{EN}}$	V <sub>EN/UVLO</sub> rising		1.2		v
Standby to Operating	Ien hys	$V_{EN/UVLO} = 1.5V$		10		μА
Hysteresis Current	1EN-IIII5	V ENVOVED = 1.5 V		10		411
Error Amplifier						
FB Reference Voltage	VREE	FB connected to COMP		800		mV
FB Input Bias Current		$V_{\rm FD} = 0.8V$		0		
The input bias current	ILR-RIV2	$V_{FB} = 0.0V$ $V_{FB} = 0V$ COMP sourcing		0		uA
COMP Output High Voltage	V <sub>COMP-OH</sub>	0.5mA		4.2		V
COMP Output Low Voltage	VCOMP-OL	COMP sinking 0.6mA		0.45		V
DC Gain	AVOL			100		dB
Unity Gain Bandwidth	GBW			6.6		MHz
Soft Start and Voltage Trackin	ıg			$\sim$		
SS/TRK Capacitor Charging	т	N/ ON		10	Y	
Current	ISS	$\mathbf{v}_{SS/TRK} = 0\mathbf{v}$		10		uA
SS/TRK Discharge FET	2	$V_{EN/UVLO} = 1V$ , $V_{SS/TRK} =$				0
Resistance	R <sub>SS</sub>	0.1V		28		Ω
SS/TRK to FB Offset	VSSER		6	0		mV
SS/TRK Clamp Voltage	VSS CLAMP	$V_{SS,TDV} = V_{ED} = 0.8V$		120		mV
POWER GOOD INDICATOR	V 55-CLAMP	V 55/1KK V FB, V FB - 0.0 V		120		111 V
FB Upper Infestion for	PGUTH	% of $V_{REF}$ , $V_{FB}$ rising	<b>Y</b>	108.00%		
FROOD High to Low		-	·			
FB Lower Inreshold for	PGLTH	% of V <sub>REF</sub> , V <sub>FB</sub> falling		92.00%		
PGOOD High to Low		• • • •				
PGOOD Upper Threshold	PG <sub>HYS</sub> U	% of V <sub>REF</sub>		3.00%		
Hysteresis	_					
PGOOD Lower Threshold	PG <sub>HYS</sub> L	% of V <sub>REF</sub>		2.00%		
Hysteresis	_			22		
PGOOD Rising Filter	TPG-RISE	FB to PGOOD rising edge		33		μs
PGOOD Falling Filter	T <sub>PG-FALL</sub>	FB to PGOOD falling edge		33		μs
PGOOD Low State Output	VPG-OI	$V_{\text{FR}} = 0.9 \text{ V}$ . IPGOOD = 2 mA		170		mV
Voltage	TOOL			170		
PGOOD High State Leakage	Ірд-он 🦯 🔘	$V_{FB} = 0.8V, V_{PGOOD} = 13V$		50		nA
Switching Frequency						
Switching Frequency	-	<b>D</b> (001 C		100		
Oscillator Frequency – 1	Fsw1	$R_{RT} = 100 k\Omega$		100		kHz
Oscillator Frequency – 2	Fsw2	$R_{RT} = 25 k\Omega$		400		kHz
Oscillator Frequency – 3	Fsw3	$R_{RT} = 12.5 k\Omega$		740		kHz
Synchronization Input and Ou	tput					
SYNCIN External Clock	T.	% of nominal frequency set	2004		500/	
Frequency Range	FSYNC	by R <sub>RT</sub>	-20%		50%	
Minimum SYNCIN Input	<b>X</b> 7		2			<b>X</b> 7
Logic High	V SYNC-IH		2			V
Maximum SYNCIN Input						
Logic Low	V SYNC-IL				0.8	V
SYNCIN Input Resistance	R <sub>SYNCIN</sub>	$V_{\text{SYNCIN}} = 3 \text{ V}$	1	23		kΩ
SYNCIN Input Minimum		Minimum high state or low		-		
Pulse Width	TSYNCI-PW	state duration	50			ns
SYNCOUT High State Output		ISYNCOUT = $-1 \text{ mA}$	-			
Voltage	V <sub>SYNCO-OH</sub>	(sourcing)	3			V
SYNCOUT Low State Output		$I_{SYNCOUT} = 0.4 \text{ mA}$				_
Voltage	V <sub>SYNCO-OL</sub>	(sinking)			0.4	V
Delay from HO Rising to		$V_{\text{SYNCIN}} = 0 \text{ V}.$		-		
SYNCOUT Leading Edge	TSYNCOUT	$T_s = 1/F_{sw}$ , Fsw set by RRT		$T_{\rm S}/2 - 200$		ns
			1			1



## AN\_SQ33065

Delay from SYNCIN Leading Edge to HO Rising	T <sub>SYNCIN</sub>	50% to 50%	200	ns			
Bootstrap Diode and Under Voltage Threshold							
Diode Forward Voltage, VCC to BST	VBST-FWD	VCC to BST, BST pin sourcing 20 mA	0.8	V			
BST to LX Quiescent Current, not Switching	I <sub>Q-BST</sub>	$V_{SS/TRK} = 0V,$ $V_{LX} = 48V, V_{BST} = 54V$	40	uA			
BST to LX under Voltage Detection	V <sub>BST-UV</sub>	V <sub>BST</sub> – V <sub>LX</sub> falling	3.2	V			
BST to LX under Voltage Hysteresis	V <sub>BST-HYS</sub>	$V_{BST} - V_{LX}$ rising	0.36	Ś			
PWM CONTROL				0			
Minimum Controllable on- time	TON(MIN)	$V_{BST} - V_{LX} = 7 V,$ HO 50% to 50%	60	ns			
Minimum off-time	Toff(MIN)	$V_{BST} - V_{LX} = 7 V,$ HO 50% to 50%	200	ns			
Maximum Duty Cycle	DC100kHz	$ \begin{aligned} F_{SW} &= 100 \text{ kHz}, \\ 6 \text{ V} &\leq \text{V}_{\text{VIN}} \leq 60 \text{ V} \end{aligned} $	97%				
	DC400kHz	$ F_{SW} = 400 \text{ kHz}, \\ 6 \text{ V} \le \text{V}_{\text{VIN}} \le 60 \text{ V} $	90%				
Ramp Valley Voltage (COMP at 0%duty cycle)	V <sub>RAMP(min)</sub>		300	mV			
PWM Feedforward Gain (VIN / VRAMP)	k <sub>FF</sub>	$6 \text{ V} \le \text{V}_{\text{VIN}} \le 75 \text{ V}$	15	V/V			
<b>OVERCURRENT PROTECT</b>	(OCP) – VALL	EY CURRENT LIMITING	×				
ILIM Source Current, RSENSE Mode	IRS	Low voltage detected at ILIM	100	uA			
ILIM Source Current, RDS(on) Mode	Irdson	LX voltage detected at ILIM, $T_J = 25$ °C	200	uA			
ILIM Current Tempco	IRSTC	RDS-ON mode	4500	ppm/ °C			
ILIM Current Tempco	IRDSONTC	R <sub>SENSE</sub> mode	0	ppm/ °C			
ILIM Comparator Threshold at ILIM	VILIM-TH	SV .	0	mV			
SHORT-CIRCUIT PROTECT	C (SCP) – DUTY	CYCLE CLAMP					
Clamp Offset voltage – no current Limiting	VCLAMP-OS	CLAMP to COMP steady state offset voltage 0	0.2+VIN/75	V			
Minimum Clamp Voltage	VCLAMP-MIN	CLAMP voltage with continuous current limiting 0.3 + V <sub>VIN</sub> /150	0.3+VIN/150	V			
HICCUP MODE FAULT PRO	TECTION		•				
Hiccup Mode Activation Delay	CHICC-DEL	Clock cycles with current limiting before hiccup off- time activated	128	cycles			
Hiccup Mode off-time after Activation	CHICCUP	Clock cycles with no switching followed by SS/TRK release	8192	cycles			
DIODE EMULATION							
Toro gross Datest (7(D) 9-4		ZCD threshold measured at					
start Ramp	V <sub>ZCD-SS</sub>	LX pin 50 clock cycles after first HO pulse	0	mV			
Zero-cross Detect Disable Threshold(CCM)	V <sub>ZCD-DIS</sub>	ZCD threshold measured at LX pin 1000 clock cycles after first HO pulse	200	mV			
Diode Emulation Zero-cross Threshold	V <sub>DEM-TH</sub>	Measured at LX with $V_{\rm LX}$ rising	0	mV			



Gate Driver						
HO High-state Resistance, HO	RHO-UP	$V_{BST} - V_{LX} = 7 V,$		1.8		Ω
to BST		$I_{\rm HO} = -100 \text{ mA}$		1.0		
HO Low-state Resistance, HO	Puo powa	$V_{BST} - V_{LX} = 7 V$ ,		0.7		Ω
to LX	ICHO-DOWN	$I_{HO} = 100 \text{ mA}$		0.7		
LO High-state Resistance, LO	RLO-UP	$V_{BST} - V_{LX} = 7 V$ ,		1.0		0
to VCC		$I_{LO} = -100 \text{ mA}$		1.0		52
LO Low-state Resistance, LO	D	$V_{BST} - V_{LX} = 7 V,$		0.7		0
to PGND	KLO-DOWN	$I_{LO} = 100 \text{ mA}$		0.7		52
	тт	$V_{BST} - V_{LX} = 7 V$ ,		0.0		
HO, LO Source Current	IHOH, ILOH	HO = LX, LO = AGND		2.3		
		$V_{BST} - V_{LX} = 7 V$ ,		3.9	<u>,</u> <b>(</b> )	A
HO, LO Sink Current	I <sub>HOL</sub> , I <sub>LO</sub> L	HO = BST, LO = VCC				
THERMAL SHUTDOWN						
Thermal Shutdown Threshold	T <sub>SD</sub>	T <sub>J</sub> rising		160		°C
Thermal Shutdown Hysteresis	T <sub>SD-HYS</sub>			18	<b>Y</b>	°C
Switching Characteristics						
UO LO Disa Timas	T <sub>HO-TR</sub> _T <sub>LO-</sub>	$V_{BST} - V_{LX} = 7 V, C_{LOAD} =$				
HO, LO Rise Times	TR	1 nF, 20% to 80%	· · · · · · · · · · · · · · · · · · ·	· · · · ·		118
HO, LO Fall Times	T <sub>HO-TF</sub> _T <sub>LO-</sub>	$V_{BST} - V_{LX} = 7 V, C_{LOAD} =$				
		1 nF, 80% to 20%		4		115
HO Turn on Dead Time	T <sub>HO-DT</sub>	$V_{BST} - V_{LX} = 7 V, LO off$		25		
		to HO on, 50% to 50%		25		118
LO Turn on Dood Time	Τ	$V_{BST} - V_{LX} = 7 V, HO off$		25		20
LO Turn on Dead Time	I LO-DT	to LO on, 50% to 50%		25		IIS

**Note 1**: Stresses beyond the listed "Absolute Maximum Ratings" may cause permanent damage to the device. These are for stress ratings. Functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions may remain possibility to affect device reliability.

Note 2:  $\theta_{JA}$  is measured in the natural convection at  $T_A=25$  (Con a high effective four layer PCB with thermal via according with JESD 51-2, -5, -7 measurement standard.

Note 3: The device is not guaranteed to function outside its operating conditions.



## **AN SQ33065**

## **Operation Principles**

#### **Input Voltage**

SQ33065 adopts wide range input voltage, varying from 6V to 75V. It also samples Vin value to realize Vinfeedforward to remove Vin impact on voltage loop compensation.

A resistor  $R_{VIN}(2.2\Omega)$  and a capacitor  $C_{VIN}(100 \text{pF})$  is recommended to added on Vin pin to filter the noise, as shown in Fig 3.



Fig 3. Vin Pin Connection

#### **Power Supply VCC**

In SQ33065, a LDO is connected to Vin to generate VCC voltage, providing internal logic power and gate driver power. If Vin>7.5V, output of LDO (VCC) is 7.5V. If  $V_{in}$ <7.5V, VCC will follow Vin with a small voltage drop. The maximum LDO (VCC) current ability is 50mA and it can support high power application. Usually a 2.2uF capacitor is needed to connect VCC and PGND.

There is large power loss,  $(V_{in}-7.5)*I_{VCC}$ , on LDO if  $V_{in}$ is larger than VCC (7.5V) too much. Thus, VCC can be connected to output voltage or auxiliary voltage (8V~13V), using a diode to decrease power loss on SQ33065, as shown in Fig 4. If SQ33065 detects VCC is higher than 8V, it will turn off internal LDO to decrease power loss on it. Under this condition, a diode is also needed to avoid reverse current if Vin <VAUX or Vout.



#### **EN Resistor Setting**

SQ33065 can set programmable EN/UVLO voltage with user-defined hysteresis.

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When EN pin is higher than 0.4V and lower than 1.2V, SQ33065 enters standby mode. Under standby mode, internal LDO is working and SS/TRK pin is pull down to zero with no switching. When EN pin is higher than V<sub>EN\_on</sub>=1.2V, SQ33065 is in normal operation mode and a I<sub>EN HYS</sub>=10uA current flows out of EN pin to generate Hysteresis off voltage.

R<sub>EN1</sub>&R<sub>EN2</sub> are used to set EN/UVLO voltage. V<sub>in\_on</sub> is SQ33065 working Vin pin voltage and Vin\_off is stopping working voltage. Use equation:



In some application, a remote signal is used to control SQ33065. In this application, a resistor  $R_1(100\Omega)$  is recommended to added on EN pin to avoid voltage spike caused by Lline.



Fig 6. Remote Control Circuit

#### **Frequency setting**

A resistor is must needed on RT pin to set internal basic operation frequency,  $f_{\rm RT}$ , as shown in Fig 7. The switching frequency range is from 100 kHz to 1 MHz.



Fig 7. Frequency Set

The switching frequency,  $f_s$ , can be calculated by



## AN\_SQ33065

equation below:

$$f_{s}(kHz) = f_{RT}(kHz) = \frac{10^{3}}{0.093R_{PT}(k\Omega) + 0.14}$$

#### Synchronization and DCM&CCM Selection

SQ33065 can implement synchronization by SYNCIN pin. The external clock signal added on SYNCIN pin should satisfy requirements below: Frequency range: 100 kHz~1MHz,

 $-20\% f_{\rm RT} \sim +50\% f_{\rm RT}$ 

Maximum voltage amplitude: 13V Minimum pulse width: 50ns



**Fig 8. Synchronization Function Waveform** SYNCIN pin can also be used to select DCM (discontinuous conduction mode) & CCM (continuous conduction mode).

If SYNCIN is higher than 2V, it operates under CCM. The IC also operates under CCM if synchronization is used. Take internal resistor R<sub>SYNCIN</sub> into consideration to make sure high level voltage of SYNCIN is larger than 2V if divided resistor is used here.

If SYNCIN is connected to GND, SQ33065 operates under DCM. The floating SYNCIN pin is not recommended.

When SQ33065 operates under DCM, LX will use zero crossing detection to determine if LO should be turn off. Under light load or no load condition, the power loss will decrease if SQ33065 works under DCM, however the light load transient will be slower.

DCM is also applied during start-up to prevent reverse current, whatever SYNCIN is high or low voltage. Finally, DCM changes to CCM gradually if SYNCIN is high level or it operates under synchronization.



#### Fig 9. CCM&DCM Selection Soft Start&Tracking Function

When EN pin is above 1.2V, a 10uA current flows out of SS/TRK pin to charge external capacitor. This can control amplifier's reference voltage to program soft start time. The  $C_{SS}$  can be set by using the equation:



 $t_{SS}$  is set soft start time,  $I_{SS}$ =10uA,  $V_{REF}$ =0.8V. Minimum C<sub>SS</sub> capacitance is 2.2nF.



Fig 10. Tracking and PGOOD Function Waveform Customers can also connect a signal to SS/TRK pin to let output voltage track the added control signal. The typical waveform of  $V_{out}$ , SS/TRK, PGOOD is shown in Fig 10.

The control signal can be divided output voltage of master or a voltage source. The circuit of two tracking configurations following a master is shown in Fig 11.







#### PGOOD Indicator

PGOOD pin is used to reflect output voltage state, by detecting FB voltage as shown in Fig 10. When the FB voltage exceeds 94%  $V_{REF}$ , with 2% hysteresis, the switch  $S_{PGOOD}$  turns off and when the FB voltage exceeds 108%  $V_{REF}$ , the switch  $S_{PGOOD}$  turns on, pulling PGOOD low, with 3% hysteresis. The switch  $S_{PGOOD}$  turn on or turn off delay time is 25 µs.

PGOOD pin can be used as shown in Fig 12. PGOOD pin should be connected to a resistor,  $10k\Omega \sim 100k\Omega$ , and pull up to a DC voltage, usually VCC pin. When PGOOD is pull up to the DC voltage, it means output has been established. Then, PGOOD can be connected to next system to indicator if V<sub>out</sub> has been established.



#### Fig 12. PGOOD Controlling EN/UVLO Type-III Voltage Mode Control (COMP&FB)

SQ33065 adopts voltage-mode control, Type-III circuit, compensation with feed-forward,  $k_{FF}=15V/V$ . It has two zeros and three poles to compensate zeros and poles caused by the systems. COMP pin is output of error amplifier, of which gain and bandwidth are both extremely large. FB pin is output voltage feed back pin, connected to negative input of the amplifier. The positive input of the amplifier is precise 800mV reference voltage. The detailed design method will be presented later.

#### Gate Driver

SQ33065 has at least 2A source current and 3A sink current, so it can be used in large current application, where  $Q_g$  is large or even two MOSFETs are used in parallel. The large current ability means fast turn on&turn off speed and switching loss can be reduced. The maximum voltage of LO is VCC voltage and VCC supplies the LO power. VCC also charges a external 0.1uF BST\_LX capacitor, through integrated bootstrap diode, which supplies HO power. Thus, the maximum voltage of HO is VCC minus V<sub>BST-FWD</sub> and V<sub>BST-FWD</sub> is bootstrap diode voltage drop.

Adaptive dead time is used in switching interval to avoid shoot through.

#### Programmable OCP

SQ33065 can set programmable OCP as circuit below. In Fig 13(a), voltage drop on  $R_{dson}$  is sampled, without any extra power loss, while in Fig 13(b), a sampling resistor is needed and voltage across it is sampled. SQ33065 compares the ILIM pin voltage with internal reference each duty cycle to determine if  $I_L$  exceeds set OCP threshold.



Fig 13(b). Programmable OCP Rsense Mode Under different implementations, OCP current I<sub>ILIM</sub> through ILIM pin is different. I<sub>LIM\_Rds\_on</sub>=200uA @25 °C, which incorporates a TC of +4500 ppm/°C, in Fig 13(a)  $R_{ds_on}$  mode and I<sub>LIM\_RS</sub>=100uA and it will not change @-25 °C~125 °C in Fig 13(b)  $R_{sense}$  mode. A resistor  $R_{ILIM}$  is connected between ILIM pin and sampling point. The  $R_{ILIM}$  can be set as equation below:

$$R_{ILIM} = \begin{cases} \frac{(I_{OUT} - \Delta I_{L} / 2)R_{ds_on_Q2}}{I_{LIM_Rds_on}}, R_{ds_on} \text{ mode} \\ \frac{(I_{OUT} - \Delta I_{L} / 2)R_{S}}{I_{LIM_RS}}, R_{sense} \text{ mode} \end{cases}$$

In order to avoid voltage ring impact, a capacitor  $C_{ILIM}$  connected between ILIM to PGND is essential. Approximately 6 ns of  $R_{ILIM} \cdot C_{ILIM}$  is recommended.







Fig 14 shows the OCP logic, CLAMP is internal signal which is used to limit large inductor current when output shorts, RAMP is PWM waveform. If the over current condition that OCP signal is high level when SQ33065 detects inductor current, lasts for 128 continuous clock cycles, OCP is triggered and SS is pulled low for 8192 clock cycles. Then SQ33065 enters auto recovery state.

#### Thermal Shutdown

SQ33065 monitors die temperature under normal operating mode. Once die temperature rises above internal OTP threshold, IC will stop switching. If die temperature is lower than hysteresis temperature, SQ33065 enters auto recovery state.

## Power Stage Design Guide

#### Inductor calculation

Choose the inductance to provide the desired ripple current  $\Delta I_L$ , between 30% and 40% of the maximum DC output current at nominal input voltage. The inductance is calculated as:



The DCR of the inductor and the core loss at the switching frequency must be low enough to achieve the desired efficiency. When SQ33065 operates under maximum or large duty, voltage drop on DCR of the inductor should be considered. Check the datasheet of the inductor whether its saturation current is higher than inductor peak current under OCP.

#### **Output Capacitors**

Output capacitor  $C_{OUT}$  filters the inductor ripple current and stores the energy supplying to the load. Therefore, both steady state ripple and transient requirements must be taken into consideration when select the capacitor. Capacitance is selected as equation below:

$$C_{out} \ge \frac{\Delta I_{L}}{8f_{s}\sqrt{\Delta V_{out}^{2} - (R_{ESR}\Delta I_{L})^{2}}}$$
$$C_{out} \ge \frac{L_{F}\Delta I_{out}^{2}}{(V_{out} + \Delta V_{overshoot})^{2} - V_{out}^{2}}$$

Tantalum and electrolytic capacitors supply a large bulk capacitance to store energy while ceramic capacitors are usually added due to its low ESR to reduce the output voltage ripple.

#### Input Capacitors

Input capacitor  $C_{in}$  is necessary to reduce input voltage ripple. X5R or X7R ceramic capacitors are recommended to provide low input impedance. The input capacitance is calculated as below:

$$E_{in} > \frac{D(I-D)I_{out}}{f_s(\Delta V_{in} - R_{ESR}I_{out})}$$

#### Power MOSEET

MOSFET selection is important in DCDC converter design. The low  $R_{dson}$  of MOSFET can bring low conduction loss to achieve high efficiency. While low  $R_{dson}$  MOSFET has large  $Q_g$ , which leads to more switching loss. It is a trade-off to select suitable  $R_{dson}$  and  $Q_g$ . Low thermal resistance is also needed and it can make power loss result in low temperature. Besides, maximum current and voltage should be satisfied.

MOSFET power losses are calculated below, where suffixes 1 and 2 represent high-side and low-side MOSFET parameters, respectively.

1. Conduction loss

$$\begin{split} P_{cond} = & D(I_{out}^2 + \Delta I_L^2 / 12) R_{dson1} + (1 - D)(I_{out}^2 + \Delta I_L^2 / 12) R_{dson2} \\ 2. \ Switching \ loss \end{split}$$

 $P_{sw} = V_{in} f_s (I_{Lmin} t_r + I_{Lmax} t_f)$ 

 $t_{\rm f}$  and  $t_{\rm f}$  are LX rising and falling time. Only high-side MOSFET switching loss is calculated and low-side MOSFET switching loss is negligible.

3. Gate driver loss

#### $P_{gate} = V_{CC} f_s(Q_{g1} + Q_{g2})$

The approximate calculation of gate driver loss is based on the MOSFET internal gate resistance, the added series gate resistance and the SQ33065 internal driver resistance.

4. Output charge loss

 $P_{coss} = f_s(V_{in}Q_{oss2} + E_{oss1} - E_{oss2})$ 

 $E_{oss1}$  is the energy stored in  $C_{oss1}$  and dissipated at turn on, but this is offset by the stored energy  $E_{oss2}$  on  $C_{oss2}.$ 

5. Body diode conduction loss

```
P_{diode\_cond} = V_{F2} f_s(I_{Lmin} t_{dt1} + I_{Lmax} t_{dt2})
```



 $V_{F2}$  is body diode conduction voltage. Only low-side MOSFET body diode conduction loss is calculated.

6. Body diode reverse recovery loss

 $P_{RR} = V_{in} f_s Q_{RR2}$ 

 $Q_{\text{RR2}}$  is low-side MOSFET body diode reverse recovery charge.

## Voltage Loop Design Guide

#### **Control Loop Compensation Design**

SQ33065 use voltage-mode control, Type-III circuit, with  $V_{\rm in}$  feedback forward, where two zeros and three poles are used in compensation. The control circuit is shown below.



#### Fig 15. Control Loop Circuit

One pole is located at the origin to achieve high DC gain. The second pole is added on  $1/2f_s$  to suppress high frequency noise. The last pole is usually located at  $f_{ESR}$ , which is caused by ESR of output capacitor.

The two zeros are used to compensate LC resonance poles. The added poles and zeros are shown in picture below.





$$G_{vd}(s) = \frac{V_{in}(1 + \frac{s}{\omega_{ESR}})}{1 + \frac{s}{Q_0\omega_0} + \frac{s^2}{\omega_0^2}}$$

Where

$$\omega_{0} = \frac{1}{\sqrt{L_{F}C_{out}}}$$
$$\omega_{0} = \frac{1}{R_{ESR}C_{out}}$$
$$Q_{0} = \frac{R_{o}}{\sqrt{L_{F}/C_{out}}}$$

**AN SO33065** 

Following compensation in control toop circuit, there is a PWM comparator. The amplitude of the PWM is  $V_{in}/k_{FF}$ ,  $V_{in}$  feed forward, and finally, the stability has nothing with  $V_{in}$ . The transfer function of PWM comparator is shown below.

$$G_{M}(s) = \frac{1}{V_{RAMP}} = \frac{k_{FF}}{V_{in}}$$

The compensator transfer function is shown below:

$$G_{c}(s) = K_{mid} \frac{(1 + \frac{\omega_{z1}}{s})(1 + \frac{s}{\omega_{z2}})}{(1 + \frac{s}{\omega_{p1}})(1 + \frac{s}{\omega_{p2}})}$$

The small signal open loop response of buck converter is the product of power stage, compensator and PWM comparator transfer functions:

$$T_{vd}(s) = G_{vd}(s)G_M(s)G_c(s)$$

$$= K_{mid} \frac{(1 + \frac{\omega_{z1}}{s})(1 + \frac{s}{\omega_{z2}})}{(1 + \frac{s}{\omega_{p1}})(1 + \frac{s}{\omega_{p2}})} \frac{1 + \frac{s}{\omega_{ESR}}}{1 + \frac{s}{Q_0\omega_0} + \frac{s^2}{\omega_0^2}} k_{FF}$$

In Fig 15,  $R_{FB1}\&R_{FB2}$  are divider resistor and they determine the desired  $V_{\text{out}}.$ 

Here provides a simplified compensator parameters design method:

1. R<sub>FB2</sub>&R<sub>FB2</sub> calculation:

=

RFB1 is selected for  $1k\Omega{\sim}5k\Omega$  and  $R_{FB1}$  can be calculated:

$$R_{FB1}=R_{FB2}(V_{out}/V_{REF}-1)$$

2. Select  $\omega_c$  and  $K_{mid}$  calculation

 $\omega_c$  is crossing radian frequency and usually:

$$\omega_{\rm c} = 1/10 \sim 1/5 \,\omega_{\rm c}$$

 $K_{mid}$  (mid-frequency gain) can be calculated approximatively:

$$K_{mid} = \omega_c / (\omega_0 k_{FF})$$

 $k_{FF}$ =15 is SQ33065 feedforward parameter.  $R_2$  can be calculated:

$$R_2 = K_{mid}R_{FB1}$$

3. 
$$\omega_{z1} \& \omega_{z2}$$
 calculation



These zeros are needed to cancel the LC oscillation peak and their value can be selected as below:

#### $\omega_{z_1}=0.5\,\omega_0,\ \omega_{z_2}=\omega_0$

Usually output capacitor has serial parasitic resistor and a zero is located at  $R_{ESR}C_{out}$ . A pole is needed here to reduce ESR impact. Final pole is usually located at  $\omega_s/2(\omega_s=2\pi f_s)$  to restrain switching frequency influence:  $\omega_{p1}=\omega_{ESR}, \ \omega_{p2}=\omega_s/2$ 

4. Compensator resistor and capacitor calculation Once poles and zeros' value are determined, in compensator, these poles and zeros are fabricated by the resistor and capacitors and can be calculated as below:

$$C_2=1/\omega_{z1}R_2, C_3=1/\omega_{p2}R_2$$
  
 $C_1=1/\omega_{z2}R_{FB1}, R_1=1/\omega_{p1}C_1$ 

Referring to Fig 15, the phase margin,  $\Phi_M$ , is the difference between the loop phase at  $\omega_c$  and  $-180^\circ$ . Usually, 50° to 70  $\Phi_M$  in design is considered ideal.

## **EMI Filter Design Guide**



#### Fig 17. Buck EMI Filter

The EMI filter design steps are as follows: 1. Calculate the required attenuation of the EMI filter at the switching frequency

Attn = 
$$20 \log(\frac{I_{peak} \cdot 1\mu V}{\pi^2 f_s C_{in}}) \sin(\pi D_{max}) - V_{max}$$

Vmax is the allowed  $dB\mu V$  noise level for the applicable EMI standard.

2. Input filter inductor  $L_{IN}$  is usually selected between 1 ~10  $\mu$ H. It can be lower to reduce losses in a high current design;

3. Calculate input filter capacitor C<sub>F</sub>

$$\mathbf{C}_{\mathrm{F}} = \frac{1}{\mathrm{L}_{\mathrm{IN}}} \left( \frac{10^{\frac{|\mathrm{Attn}|}{40}}}{2\pi f_{\mathrm{s}}} \right)^{2}$$

The output impedance of the EMI filter must be extremely small and the EMI filter does not affect the loop gain of the buck converter. The resonant frequency of the EMI filter is:

$$f_{\rm res\_filter} = \frac{1}{2\pi\sqrt{L_{\rm IN}C_{\rm F}}}$$

 $R_D$  is used to reduce the peak output impedance at  $f_{res\_filter}$  to reduce EMI filter impact on loop gain of the buck

converter. C<sub>D</sub> blocks the DC component of the input voltage to avoid power loss in R<sub>D</sub>. C<sub>D</sub> should have lower impedance than R<sub>D</sub> at  $f_{\text{res}_filter}$  with a capacitance value greater than that of the input capacitor C<sub>IN</sub>:  $C_D \ge 4C_{IN}$ 

Select the damping resistor R<sub>D</sub>:

 $R_{\rm D} = \sqrt{\frac{L_{\rm IN}}{C_{\rm IN}}}$ 

# one

## Layout Considerations

A proper PCB design must follow the below guidelines: (a) To achieve a good EMI performance and to reduce the switching frequency voltage ripples, the output of the EMI rectifier should be connected to the  $C_{IN}$  capacitor first, then to the switching circuit.

(b) The inductor should be connected to the  $C_{OUT}$  capacitor first, and then to the load for a small output voltage ripples

(c) The LX switching node being short, wide and small is benefit to EMI. The parasitic inductor here should be as small as possible to decrease LX peak ringing amplitude, which may be exceed maximum voltage stress of MOSFET. If the LX peak ringing amplitude is excessive, the snubber between LX and GND is needed (d) Input capacitors, output capacitors, inductors and MOSFETs are placed on the top side of the PCB for a good cooling environment.

(e) The circuit loop of all switching circuit should be kept as small as possible to decrease disturbance as shown in Fig. 18: High-side&Low-side power loop, High-side&Low-side driver circuit loop.

(f)  $C_{BST}$  and  $C_{VCC}$  should be as close as possible to the IC to minimize the loop. High-side&Low-side driver circuit loops are also should be small. Placing a  $2\Omega$  to  $10\Omega$  resistor in series with CBST to slows down high-side MOSFET turn on speed can reduce the LX peak ringing amplitude.



Fig 18. Switching Loop in Buck

(g) Small signal ground should be different part with power ground to avoid noise from power stage. COMP, FB, RT, ILIM, SS/TRK, SYNCIN pin should be away





from LX, BST, HO, LO pin to avoid disturbances. Use internal layer as ground plane if possible.

(h) The distance between LX and ILIM pin where ILIM resistor is set should be as close as possible.

(i) Connect the PGND pin to the system ground plane using an array of vias under the exposed pad. Connect













## **Taping & Reel Specification**

## 1. QFN3.5×4.5-20 taping orientation



## 3. Others: NA

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